

Applicant: John W. Haim
Application No.: 10/077,077

measuring device 73 into which the received signal is also input which device 73 produces a data quality signal. The data quality measuring device 73 is coupled with a processor 74 which receives the signal quality data and computes target signal to interference ratio (SIR) data based upon a user defined quality standard parameter received through an input 75.

Please replace paragraph 43 on page 11 with the following:

The transmitting station's scale factor processor 55 has an input 58 associated with the transmitting station's receiver 56. The processor 55 receives the up/down command signal through input 58 and computes the transmit power scale factor based thereon.

REMARKS

Early consideration and allowance of pending claims 1 - 8 are respectfully requested.

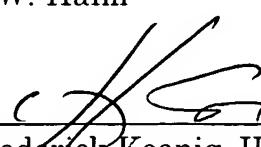
Respectfully submitted,

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Enclosures

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